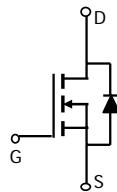
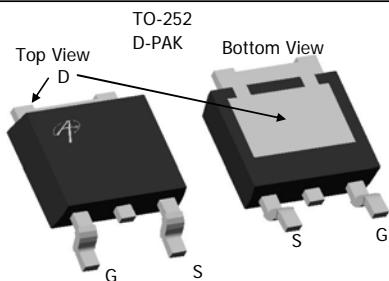


## AOD480

### N-Channel Enhancement Mode Field Effect Transistor

| General Description  | Features   |
|--|--|
| <p>The AOD480 uses advanced trench technology and design to provide excellent <math>R_{DS(ON)}</math> with low gate charge. This device is suitable for use in PWM, load switching and general purpose applications.</p> <ul style="list-style-type: none"> <li>-RoHS Compliant</li> <li>-Halogen Free*</li> </ul> | <p><math>V_{DS}</math> (V) = 30V<br/> <math>I_D</math> = 25A (<math>V_{GS}</math> = 10V)<br/> <math>R_{DS(ON)} &lt; 23 \text{ m}\Omega</math> (<math>V_{GS}</math> = 10V)<br/> <math>R_{DS(ON)} &lt; 36 \text{ m}\Omega</math> (<math>V_{GS}</math> = 4.5V)</p> <p><b>100% UIS Tested!</b><br/> <b>100% <math>R_g</math> Tested!</b></p> |



#### Absolute Maximum Ratings $T_A=25^\circ\text{C}$ unless otherwise noted

| Parameter   | Symbol         | Maximum    | Units |
|---|----------------|------------|-------|
| Drain-Source Voltage                                      | $V_{DS}$       | 30         | V     |
| Gate-Source Voltage                                       | $V_{GS}$       | $\pm 20$   | V     |
| Continuous Drain Current <sup>G</sup>                     | $I_D$          | 25         | A     |
| $T_C=100^\circ\text{C}$                                   |                | 20         |       |
| Pulsed Drain Current <sup>C</sup>                         | $I_{DM}$       | 45         |       |
| Avalanche Current <sup>C</sup>                            | $I_{AR}$       | 13         | A     |
| Repetitive avalanche energy $L=0.3\text{mH}$ <sup>C</sup> | $E_{AR}$       | 25         | mJ    |
| Power Dissipation <sup>B</sup>                            | $P_D$          | 33         | W     |
| $T_C=100^\circ\text{C}$                                   |                | 17         |       |
| Power Dissipation <sup>A</sup>                            | $P_{DSM}$      | 2.5        | W     |
| $T_A=70^\circ\text{C}$                                    |                | 1.6        |       |
| Junction and Storage Temperature Range                    | $T_J, T_{STG}$ | -55 to 175 | °C    |

#### Thermal Characteristics

| Parameter                                | Symbol    | Typ  | Max | Units |
|--|-----------|------|-----|-------|
| Maximum Junction-to-Ambient <sup>A</sup> | $R_{0JA}$ | 16.7 | 25  | °C/W  |
| Steady-State                             |           | 40   | 50  | °C/W  |
| Maximum Junction-to-Case <sup>B</sup>    | $R_{0JC}$ | 3.6  | 4.5 | °C/W  |

**Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)**

| Symbol                      | Parameter                             | Conditions   | Min | Typ   | Max | Units            |
|-----------------------------|---------------------------------------|--|-----|-------|-----|------------------|
| <b>STATIC PARAMETERS</b>    |                                       |  |     |       |     |                  |
| $\text{BV}_{\text{DSS}}$    | Drain-Source Breakdown Voltage        | $I_D=250\mu\text{A}, V_{GS}=0\text{V}$   | 30  |       |     | V                |
| $I_{\text{DSS}}$            | Zero Gate Voltage Drain Current       | $V_{DS}=24\text{V}, V_{GS}=0\text{V}$<br>$T_J=55^\circ\text{C}$                |     | 0.004 | 1   | $\mu\text{A}$    |
| $I_{\text{GSS}}$            | Gate-Body leakage current             | $V_{DS}=0\text{V}, V_{GS}=\pm 20\text{V}$                                      |     |       | 100 | nA               |
| $V_{\text{GS(th)}}$         | Gate Threshold Voltage                | $V_{DS}=V_{GS}, I_D=250\mu\text{A}$  | 1   | 1.6   | 2.5 | V                |
| $I_{\text{D(ON)}}$          | On state drain current                | $V_{GS}=10\text{V}, V_{DS}=5\text{V}$  | 30  |       |     | A                |
| $R_{\text{DS(ON)}}$         | Static Drain-Source On-Resistance     | $V_{GS}=10\text{V}, I_D=20\text{A}$<br>$T_J=125^\circ\text{C}$                 |     | 19    | 23  | $\text{m}\Omega$ |
|                             |                                       | $V_{GS}=4.5\text{V}, I_D=8\text{A}$  |     | 24    | 30  | $\text{m}\Omega$ |
| $g_{\text{FS}}$             | Forward Transconductance              | $V_{DS}=5\text{V}, I_D=8\text{A}$  | 10  | 24    |     | S                |
| $V_{\text{SD}}$             | Diode Forward Voltage                 | $I_S=1\text{A}, V_{GS}=0\text{V}$  |     | 0.77  | 1   | V                |
| $I_S$                       | Maximum Body-Diode Continuous Current |  |     |       | 4.3 | A                |
| <b>DYNAMIC PARAMETERS</b>   |                                       |  |     |       |     |                  |
| $C_{\text{iss}}$            | Input Capacitance                     | $V_{GS}=0\text{V}, V_{DS}=15\text{V}, f=1\text{MHz}$                           |     | 621   | 820 | pF               |
| $C_{\text{oss}}$            | Output Capacitance                    |  |     | 118   |     | pF               |
| $C_{\text{rss}}$            | Reverse Transfer Capacitance          |  |     | 85    |     | pF               |
| $R_g$                       | Gate resistance                       | $V_{GS}=0\text{V}, V_{DS}=0\text{V}, f=1\text{MHz}$                            |     | 0.8   | 1.5 | $\Omega$         |
| <b>SWITCHING PARAMETERS</b> |                                       |  |     |       |     |                  |
| $Q_g(10\text{V})$           | Total Gate Charge                     | $V_{GS}=10\text{V}, V_{DS}=15\text{V}, I_D=20\text{A}$                         |     | 11.3  | 14  | nC               |
| $Q_g(4.5\text{V})$          | Total Gate Charge                     |  |     | 5.7   | 7   | nC               |
| $Q_{\text{gs}}$             | Gate Source Charge                    |  |     | 2.1   |     | nC               |
| $Q_{\text{gd}}$             | Gate Drain Charge                     |  |     | 3     |     | nC               |
| $t_{\text{D(on)}}$          | Turn-On DelayTime                     | $V_{GS}=10\text{V}, V_{DS}=15\text{V}, R_L=0.75\Omega, R_{\text{GEN}}=3\Omega$ |     | 4.5   | 6.5 | ns               |
| $t_r$                       | Turn-On Rise Time                     |  |     | 3.1   | 5   | ns               |
| $t_{\text{D(off)}}$         | Turn-Off DelayTime                    |  |     | 15.1  | 23  | ns               |
| $t_f$                       | Turn-Off Fall Time                    |  |     | 2.7   | 5   | ns               |
| $t_{\text{rr}}$             | Body Diode Reverse Recovery Time      | $I_F=20\text{A}, dI/dt=100\text{A}/\mu\text{s}$                                |     | 15.5  | 21  | ns               |
| $Q_{\text{rr}}$             | Body Diode Reverse Recovery Charge    | $I_F=20\text{A}, dI/dt=100\text{A}/\mu\text{s}$                                |     | 7.1   | 10  | nC               |

A: The value of  $R_{\theta JA}$  is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The Power dissipation  $P_{\text{DSM}}$  is based on  $R_{\theta JA}$  and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175°C may be used if the PCB allows it.

B. The power dissipation  $P_D$  is based on  $T_{J(\text{MAX})}=175^\circ\text{C}$ , using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C: Repetitive rating, pulse width limited by junction temperature  $T_{J(\text{MAX})}=175^\circ\text{C}$ .

D. The  $R_{\theta JC}$  is the sum of the thermal impedance from junction to case  $R_{\theta JC}$  and case to ambient.

E. The static characteristics in Figures 1 to 6 are obtained using <300  $\mu\text{s}$  pulses, duty cycle 0.5% max.

F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(\text{MAX})}=175^\circ\text{C}$ .

G. The maximum current rating is limited by bond-wires.

H. These tests are performed with the device mounted on 1 in 2 FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The SOA curve provides a single pulse rating.

\*This device is guaranteed green after data code 8X11 (Sep 1<sup>ST</sup> 2008).

Rev1: Sep. 2008

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## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

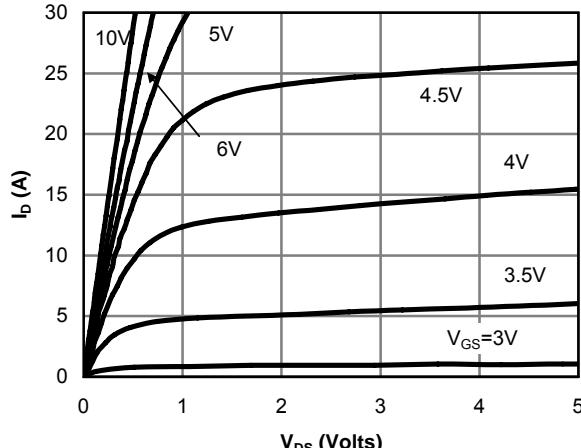


Fig 1: On-Region Characteristics

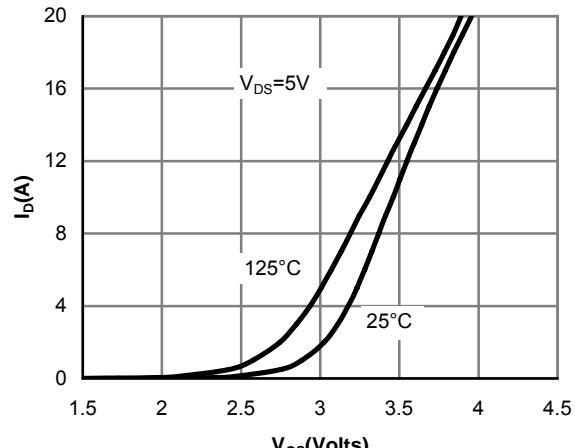


Figure 2: Transfer Characteristics

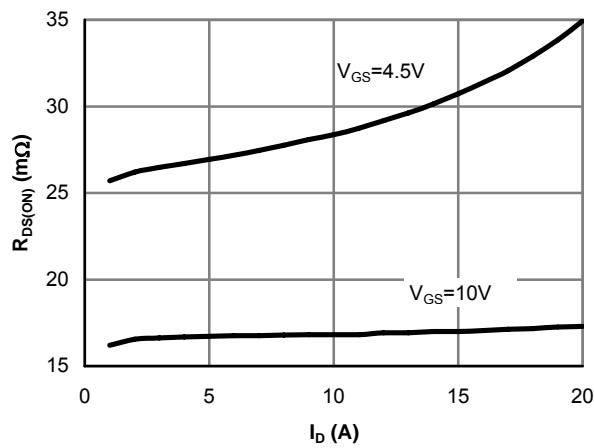


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

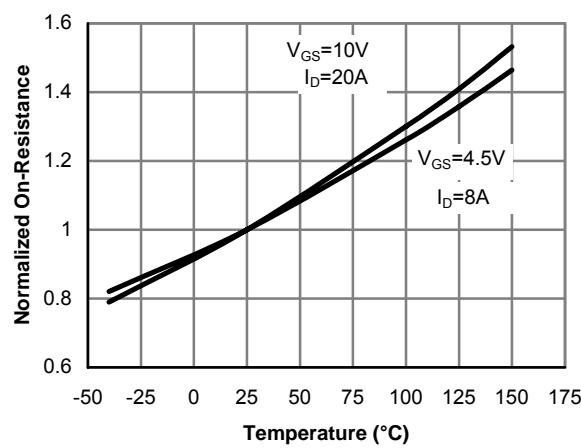


Figure 4: On-Resistance vs. Junction Temperature

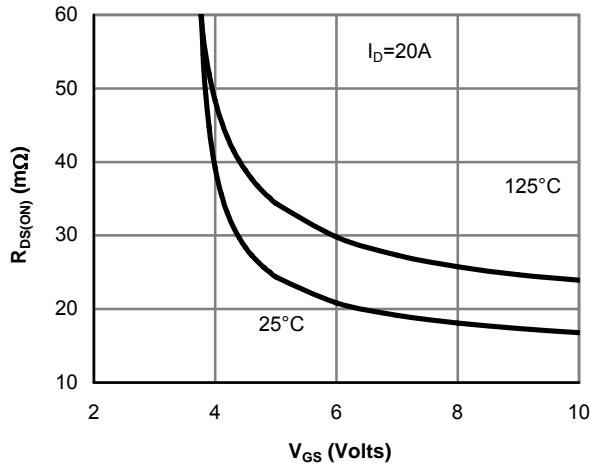


Figure 5: On-Resistance vs. Gate-Source Voltage

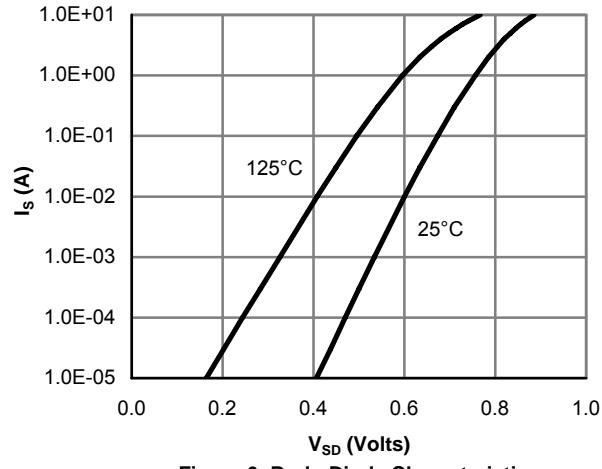
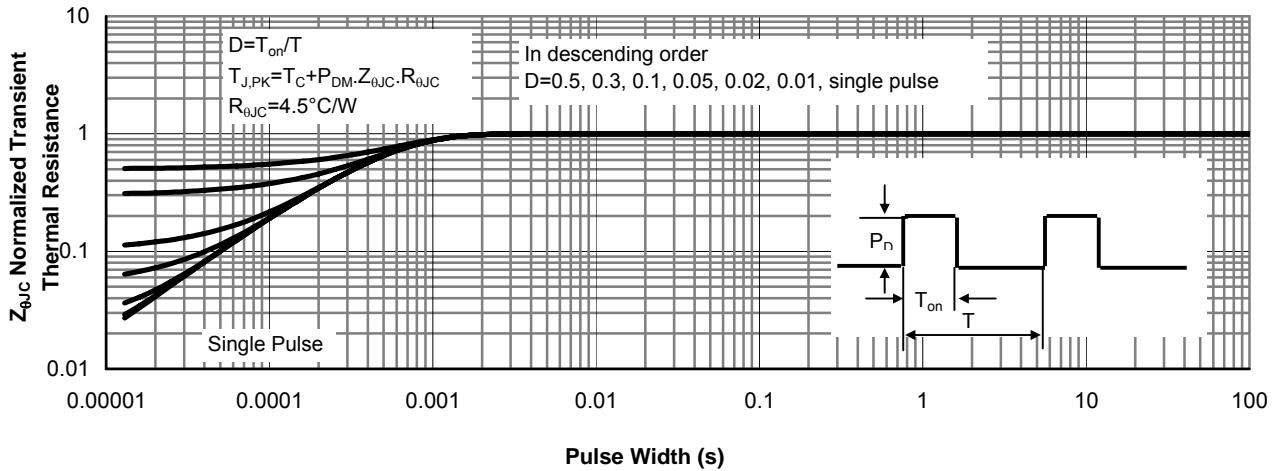
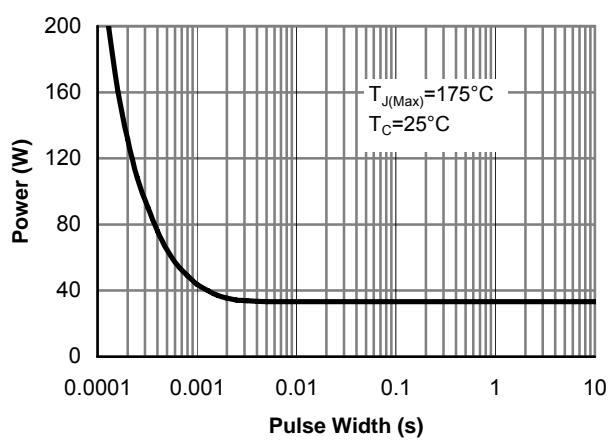
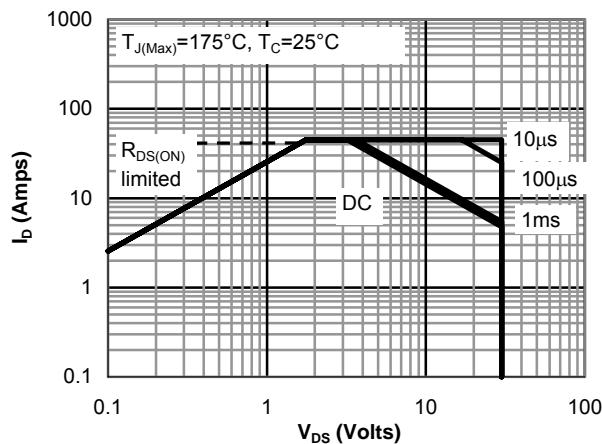
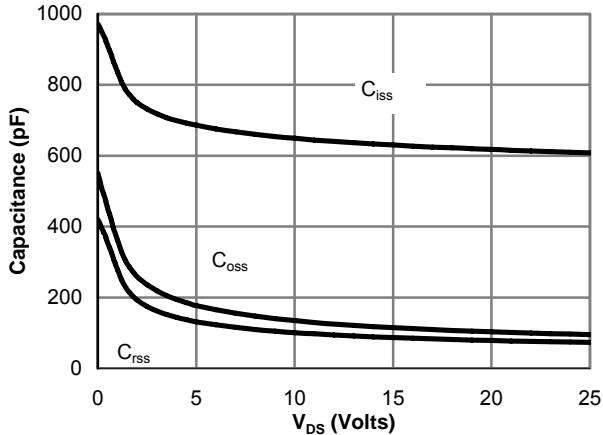
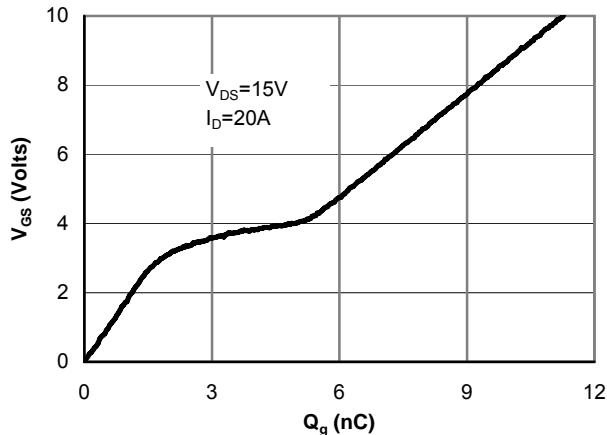


Figure 6: Body-Diode Characteristics

## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



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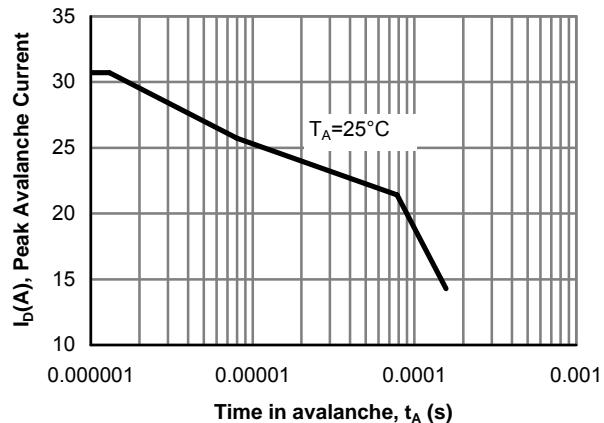
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**


Figure 12: Single Pulse Avalanche capability

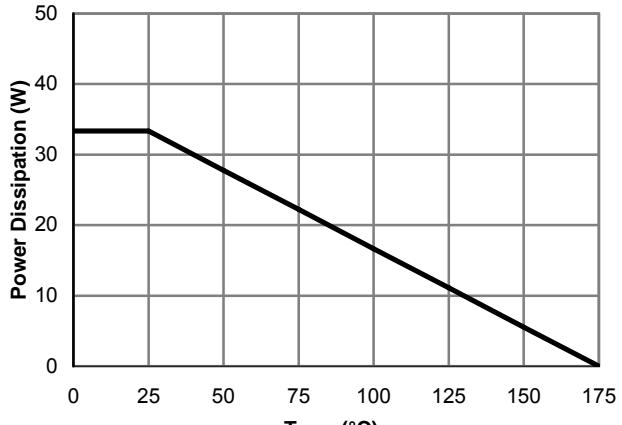


Figure 13: Power De-rating (Note B)

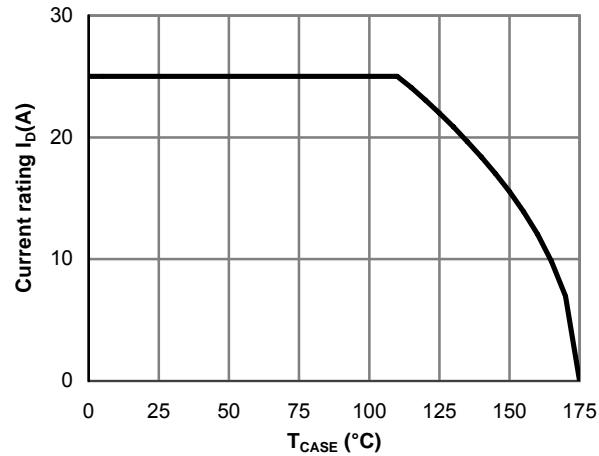


Figure 14: Current De-rating (Note B)

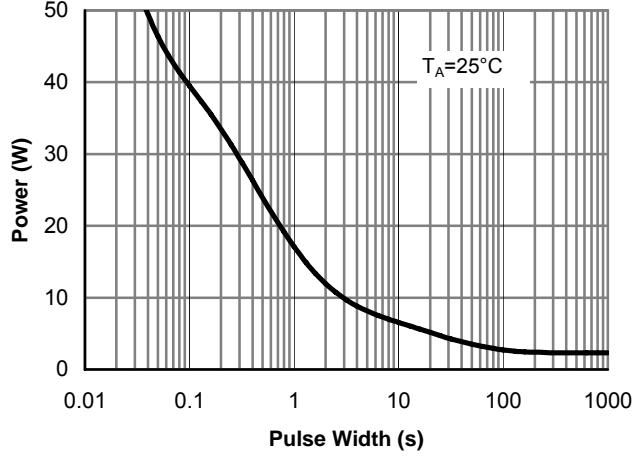


Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)

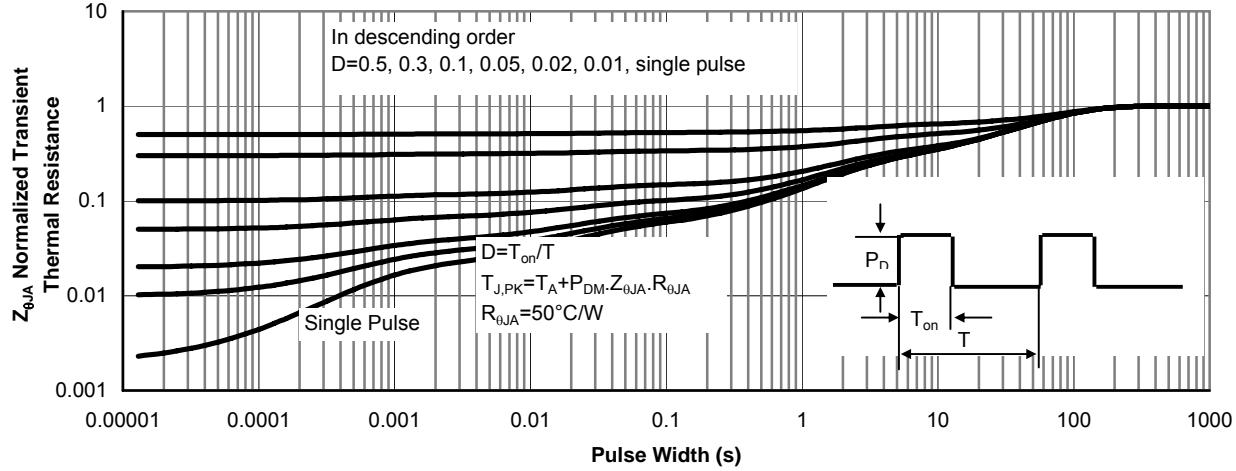
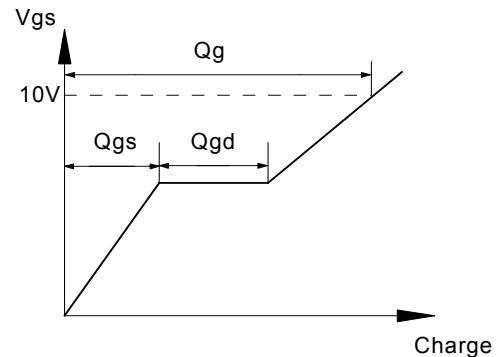
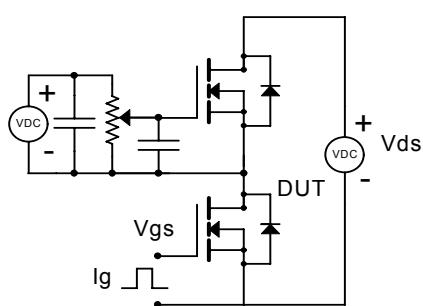
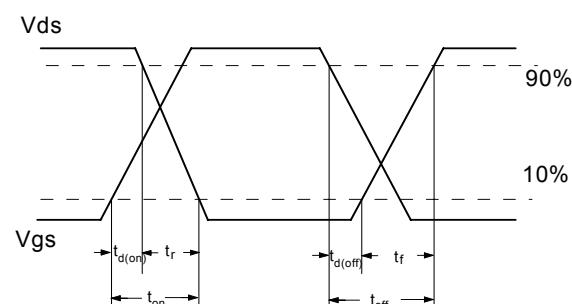
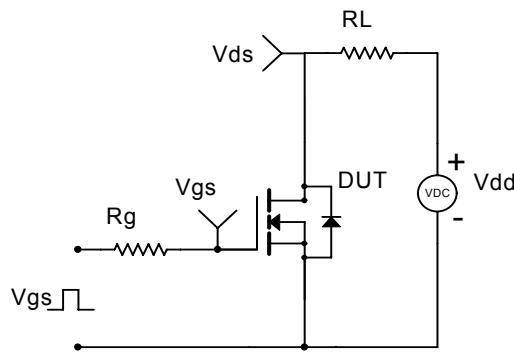


Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

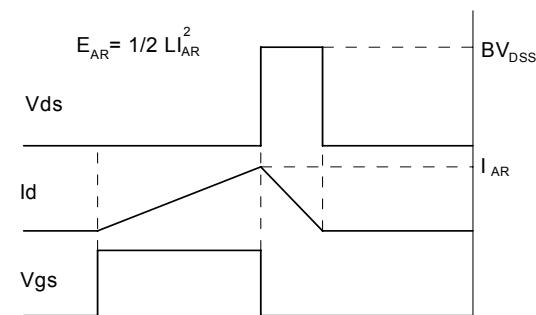
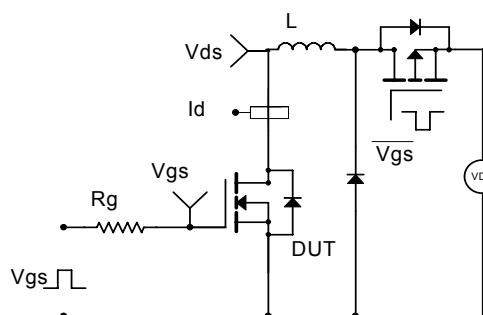
## Gate Charge Test Circuit &amp; Waveform



## Resistive Switching Test Circuit &amp; Waveforms



## Unclamped Inductive Switching (UIS) Test Circuit &amp; Waveforms



## Diode Recovery Test Circuit &amp; Waveforms

